AMENDMENTS TO THE CLAIMS:

1. (Original) An integrated circuit semiconductor-on-insulator structure, comprising:

a pair of matched transistors, in a circuit stage which requires matched behavior of said pair; and

a physical connection of semiconductor material which provides thermal conduction between respective bodies of said pair of transistors, but does not carry current during normal operation of said circuit stage; and

an insulating material which totally surrounds at least a part of said circuit stage.

- 2. (Original) The integrated circuit of Claim 1, wherein said circuit stage is an analog circuit stage.
- 3. (Original) The integrated circuit of Claim 1, wherein said circuit stage is a matched pair of current-sourcing P-channel transistors in a current mirror.
- 4. (Original) The integrated circuit of Claim 1, wherein sald circuit stage is a cascode pair.

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- 5. (Original) The integrated circuit of Claim 1, wherein said circuit stage is an input pair of a differential analog stage.
- 6. (Previously Presented) An integrated circuit semiconductor-on-insulator circuit structure, comprising:
- a pair of transistors in an analog circuit stage which requires matched behavior of said pair;
- a physical connection of metallic material which provides thermal conduction between respective bodies of said pair of transistors; and

an insulating layer beneath said pair;

an insulating barrier substantially surrounding said pair and extending to said insulating layer.

- 7. (Original) The integrated circuit of Claim 6, wherein said analog circuit stage is a current mirror.
- 8. (Original) The integrated circuit of Claim 6, wherein said analog circuit stage is a matched pair of current-sourcing P-channel transistors in a current mirror.
- 9. (Original) The integrated circuit of Claim 6, wherein said physical connection comprises metal interconnects between said transistors of said pair.

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10. (Previously Presented) An integrated semiconductor-on-insulator circuit structure, comprising:

a plurality of matched transistors in an analog circuit stage which requires matched behavior of said transistors;

wherein respective bodies of said transistors are formed from different semiconductor sections, said sections being formed on an insulating layer and at least partially separated by insulating material;

wherein said bodies are not tied to any fixed potential through a low impedance path; and

wherein said bodies are thermally coupled by a connection of non-insulating material.

- 11. (Original) The integrated circuit of Claim 10, wherein said bodies are electrically coupled by a connection of non-insulating material.
- 12. (Original) The integrated circuit of Claim 10, wherein said analog circuit stage is a current mirror.
- 13. (Original) The integrated circuit of Claim 10, wherein said connection of non-insulating material is made from semiconductor material.

14. (Canceled)

- 15. (Original) The integrated circuit of Claim 10, wherein said analog circuit stage is a matched pair of current-sourcing P-channel transistors in a current mirror.
- 16. (Original) A method of circuit operation, comprising the steps of:

 providing a pair of matched transistors, in a circuit stage which requires
 matched behavior of said pair; and

providing a physical connection of material which provides thermal conduction between respective bodies of said pair of transistors; and surrounding said circuit stage with an insulating material.

- 17. (Original) The method of Claim 16, wherein said physical connection is of a semiconductor material.
- 18. (Original) The method of Claim 16, wherein said circuit stage is an analog circuit stage.
- 19. (Original) The method of Claim 16, wherein said physical connection does not carry current during normal operation of said circuit stage.